Search Notes

Application	on/Control	No.

Applicant(s)/Patent under Reexamination

10/698,754

HAAGER ET AL.
Art Unit

Examiner

Jinhee J. Lee

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Class	Subclass	Date	Examiner
29	832	5/14/2004 \	LEE
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
29	as above	5/14/2004	LEE	
174	as above	5/14/2004	Lee	
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N. Abrans		5/14/2004	LEE
D. Tugbang		5/14/2004	LEE
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